

# MOSFET - N-Channel, POWERTRENCH®, DUAL COOL® 88

150 V, 72 A, 9.0 mΩ

# **FDMT800152DC**

## **General Description**

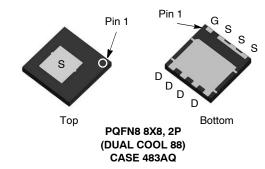
This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH process. Advancements in both silicon and DUAL COOL package technologies have been combined to offer the lowest  $R_{DS(on)}$  while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

#### **Features**

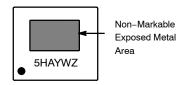
- Max  $R_{DS(on)} = 9.0 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 13 \text{ A}$
- Max  $R_{DS(on)} = 11.5 \text{ m}\Omega$  at  $V_{GS} = 6 \text{ V}$ ,  $I_D = 11 \text{ A}$
- Advanced Package and Silicon Combination for Low R<sub>DS(on)</sub> and High Efficiency
- Next Generation Enhanced Body Diode Technology, Engineered for Soft Recovery
- Low Profile 8x8 mm MLP Package
- MSL1 Robust Package Design
- 100% UIL Tested
- RoHS Compliant

## **Applications**

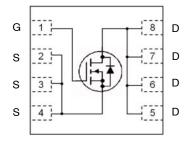
- OringFET / Load Switching
- Synchronous Rectification
- DC–DC Conversion



#### MARKING DIAGRAM



5H = Specific Device Code
A = Assembly Plant Code
YW = Date Code (Year & Week)
Z = Lot Code



#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 6 of this data sheet.

## MOSFET MAXIMUM RATINGS (T<sub>A</sub> = 25°C unless otherwise noted)

Symbol		Para	meter		Rating	Unit
V <sub>DS</sub>	Drain to Source	Voltage			150	V
V <sub>GS</sub>	Gate to Source V	/oltage			±20	V
I <sub>D</sub>	Drain Current	<ul><li>Continuous</li></ul>	T <sub>C</sub> = 25°C	(Note 5)	72	Α
		<ul><li>Continuous</li></ul>	T <sub>C</sub> = 100°C	(Note 5)	45	
		<ul><li>Continuous</li></ul>	T <sub>A</sub> = 25°C	(Note 1a)	13	
		- Pulsed		(Note 4)	413	
E <sub>AS</sub>	Single Pulse Ava	lanche Energy		(Note 3)	726	mJ
$P_{D}$	Power Dissipatio	n	T <sub>C</sub> = 25°C		113	W
	Power Dissipatio	n	T <sub>A</sub> = 25°C	(Note 1a)	3.2	
T <sub>J</sub> , T <sub>STG</sub>	Operating and St	torage Junction Temper	ature Range		-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Test Conditions	Min.	Тур.	Max.	Unit
RACTERISTICS					
Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	150	_	-	V
Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25°C	-	114	-	mV/°C
Zero Gate Voltage Drain Current	V <sub>DS</sub> = 120 V, V <sub>GS</sub> = 0 V	-	_	1	μΑ
Gate to Source Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V	-	_	100	nA
ACTERISTICS					
Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.0	2.9	4.0	V
Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25°C	-	-11	-	mV/°C
Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 13 A	-	6.9	9.0	mΩ
	V <sub>GS</sub> = 6 V, I <sub>D</sub> = 11 A	-	8.6	11.5	1
	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 13 A, T <sub>J</sub> = 125°C	-	14.6	19	1
Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 13 A	-	41	_	S
CHARACTERISTICS					
Input Capacitance	V <sub>DS</sub> = 75 V, V <sub>GS</sub> = 0 V, f = 1 MHz	-	4196	5875	pF
Output Capacitance	1	-	379	530	pF
Reverse Transfer Capacitance	1	-	16	30	pF
Gate Resistance		0.1	1.3	3.3	Ω
IG CHARACTERISTICS					
Turn-On Delay Time	V <sub>DD</sub> = 75 V, I <sub>D</sub> = 13 A,	-	24	39	ns
Rise Time	$V_{GS} = 10 \text{ V}, H_{GEN} = 6 \Omega$	-	13	23	ns
Turn-Off Delay Time	]	-	36	58	ns
Fall Time	]	-	7.9	16	ns
Total Gate Charge	$V_{GS} = 0 \text{ V to } 10 \text{ V}, V_{DD} = 75 \text{ V}, I_D = 13 \text{ A}$	-	59	83	nC
	$V_{GS} = 0 \text{ V to } 6 \text{ V}, V_{DD} = 75 \text{ V}, I_D = 13 \text{ A}$	-	38	53	
Gate to Source Charge	V <sub>DD</sub> = 75 V, I <sub>D</sub> = 13 A	-	18	-	nC
Gate to Drain "Miller" Charge	1	-	12	-	nC
DURCE DIODE CHARACTERISTICS					
Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.9 A (Note 2)	-	0.7	1.1	V
	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 13 A (Note 2)	_	0.8	1.2	
Reverse Recovery Time	I <sub>F</sub> = 13 A, di/dt = 100 A/μs	-	95	152	ns
Reverse Recovery Charge		_	187	299	nC
	Breakdown Voltage Temperature Coefficient  Zero Gate Voltage Drain Current Gate to Source Leakage Current  ACTERISTICS  Gate to Source Threshold Voltage Gate to Source Threshold Voltage Temperature Coefficient  Static Drain to Source On Resistance  Forward Transconductance  CHARACTERISTICS  Input Capacitance Output Capacitance  Gate Resistance  GCHARACTERISTICS  Turn-On Delay Time Rise Time  Turn-Off Delay Time  Fall Time  Total Gate Charge  Gate to Source Charge  Gate to Source Charge  Gate to Drain "Miller" Charge  DURCE DIODE CHARACTERISTICS  Source to Drain Diode Forward Voltage  Reverse Recovery Time	RACTERISTICS         Drain to Source Breakdown Voltage $I_D = 250 \mu A$ , $V_{GS} = 0 V$ Breakdown Voltage Temperature Coefficient $I_D = 250 \mu A$ , referenced to $25^{\circ}C$ Zero Gate Voltage Drain Current $V_{DS} = 120 \text{ V}$ , $V_{QS} = 0 \text{ V}$ Gate to Source Leakage Current $V_{GS} = \pm 20 \text{ V}$ , $V_{DS} = 0 \text{ V}$ ACTERISTICS       Gate to Source Threshold Voltage $I_D = 250 \mu A$ , referenced to $25^{\circ}C$ Gate to Source Threshold Voltage Temperature Coefficient $I_D = 250 \mu A$ , referenced to $25^{\circ}C$ Static Drain to Source On Resistance $V_{GS} = 10 \text{ V}$ , $I_D = 13 \text{ A}$ VGS = 10 V, $I_D = 13 \text{ A}$ $V_{GS} = 10 \text{ V}$ , $I_D = 13 \text{ A}$ VGS = 10 V, $I_D = 13 \text{ A}$ $V_{DS} = 5 \text{ V}$ , $V_{DS} = 0 \text{ V}$ , $V_{DS} = 10 \text{ MHz}$ Input Capacitance $V_{DS} = 75 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $V_{CS} = 0 $	AACTERISTICS         Drain to Source Breakdown Voltage $I_D = 250 \mu A$ , $V_{GS} = 0 V$ 150         Breakdown Voltage Temperature Coefficient $I_D = 250 \mu A$ , referenced to 25°C       -         Zero Gate Voltage Drain Current $V_{DS} = 120 \text{ V}$ , $V_{QS} = 0 \text{ V}$ -         Gate to Source Leakage Current $V_{QS} = \pm 20 \text{ V}$ , $V_{DS} = 0 \text{ V}$ -         ACTERISTICS $I_D = 250 \mu A$ , referenced to 25°C       -         Gate to Source Threshold Voltage Temperature Coefficient $I_D = 250 \mu A$ , referenced to 25°C       -         Static Drain to Source On Resistance $V_{QS} = 10 \text{ V}$ , $I_D = 13 \text{ A}$ -         Vas = 10 V, $I_D = 13 \text{ A}$ , $I_D = 125^{\circ}C$ -         Forward Transconductance $V_{DS} = 5 \text{ V}$ , $I_D = 13 \text{ A}$ -         Forward Transconductance $V_{DS} = 5 \text{ V}$ , $I_D = 13 \text{ A}$ -         CHARACTERISTICS       Input Capacitance $I_D = 100 \text{ A}$ -         Input Capacitance $I_D = 100 \text{ A}$ -       -         GCHARACTERISTICS       Input Capacitance $I_D = 100 \text{ A}$ -         Input Capacitance $I_D = 100 \text{ A}$ -       -         Input Capacitance $I_D = 100 \text{ A}$ -       -         Input	Drain to Source Breakdown Voltage   I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V   150   -	ACTERISTICS  Drain to Source Breakdown Voltage $I_{D} = 250  \mu A,  V_{GS} = 0  V$ 150

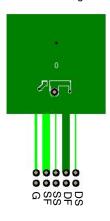
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### THERMAL CHARACTERISTICS

Symbol	Parameter		Ratings	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	(Top Source)	2.0	°C/W
$R_{ heta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	1.1	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	34	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	14	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	60	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	15	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	21	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	9	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1I)	11	

#### NOTES:

 R<sub>0,JA</sub> is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R<sub>0CA</sub> is determined by the user's board design.



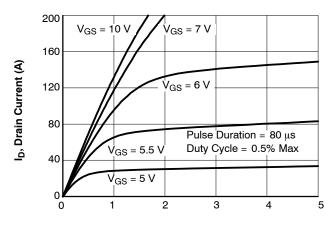
 a) 38°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b) 81°C/W when mounted on a minimum pad of 2 oz copper.

- c) Still air, 20.9 x 10.4 x 12.7 mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- d) Still air, 20.9 x 10.4 x 12.7 mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e) Still air, 45.2 x 41.4 x 11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- f) Still air, 45.2 x 41.4 x 11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g) 200FPM Airflow, No Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- h) 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper
- i) 200FPM Airflow, 20.9 x 10.4 x 12.7 mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- j) 200FPM Airflow, 20.9 x 10.4 x 12.7 mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k) 200FPM Airflow, 45.2 x 41.4 x 11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- l) 200FPM Airflow, 45.2 x 41.4 x 11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%.
- 3. E<sub>AS</sub> of 726 mJ is based on starting T<sub>J</sub> = 25°C; N-ch: L = 3 mH, I<sub>AS</sub> = 22 A, V<sub>DD</sub> = 150 V, V<sub>GS</sub> = 10 V. 100% test at L = 0.1 mH, I<sub>AS</sub> = 69 A.
- 4. Pulsed Id please refer to Figure 11 SOA graph for more details.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

## TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)



Drain to Source On-Resistance Normalized

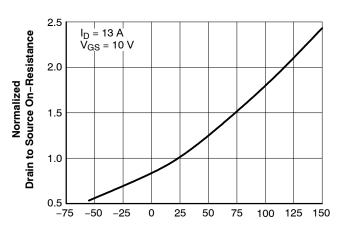
V<sub>GS</sub> = 5 V V<sub>GS</sub> = 5.5 V 3 V<sub>GS</sub> = 6 V V<sub>GS</sub> = 7 V V<sub>GS</sub> = 10 V Pulse Duration = 80 μs Duty Cycle = 0.5% Max 0 0 40 160

ID, Drain Current (A)

200

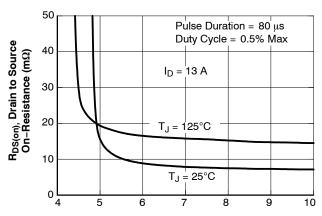
V<sub>DS</sub>, Drain to Source Voltage (V) Figure 1. On-Region Characteristics





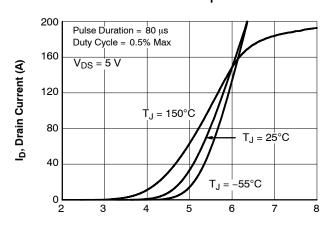
T<sub>J</sub>, Junction Temperature (°C)

Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage



V<sub>GS</sub>, Gate to Source Voltage (V)

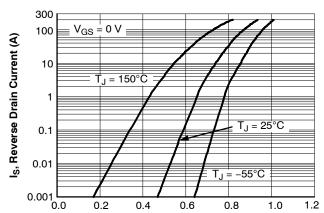
Figure 3. Normalized On-Resistance vs. **Junction Temperature** 



V<sub>GS</sub>, Gate to Source Voltage (V)

Figure 5. Transfer Characteristics





V<sub>SD</sub>, Body Diode Forward Voltage (V)

Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

## TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)(continue)

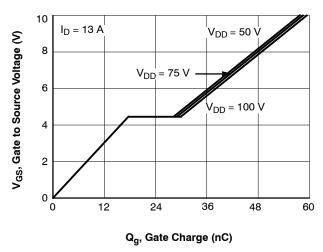
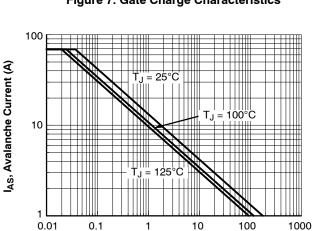
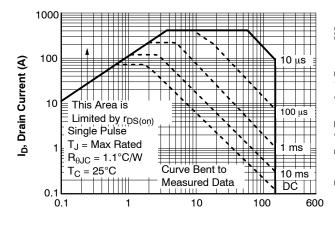


Figure 7. Gate Charge Characteristics



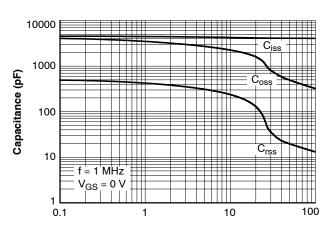
t<sub>AV</sub>, Time in Avalanche (ms)

Figure 9. Unclamped Inductive Switching Capability



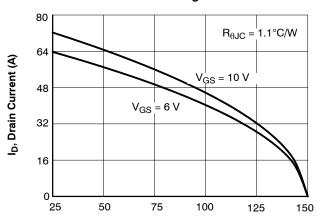
V<sub>DS</sub>, Drain to Source Voltage (V)

Figure 11. Forward Bias Safe Operating Area



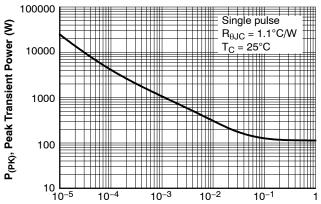
V<sub>DS</sub>, Drain to Source Voltage (V)

Figure 8. Capacitance vs. Drain to Source Voltage



T<sub>C</sub>, Case Temperature (°C)

Figure 10. Maximum Continuous Drain Current vs. Case Temperature



t, Pulse Width (s)

Figure 12. Single Pulse Maximum Power Dissipation

## TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)(continued)

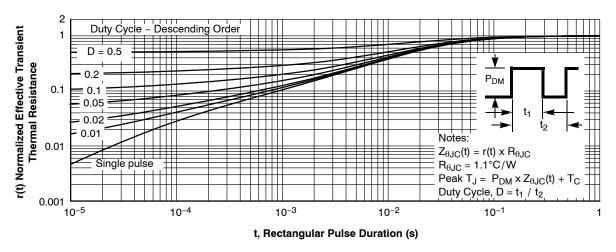


Figure 13. Junction-to-Case Transient Thermal Response Curve

## **ORDERING INFORMATION**

Device Marking	Device	Package	Reel Size	Tape Width	Shipping <sup>†</sup>
5H	FDMT800152DC	PQFN8 8X8, 2P, DUAL COOL 88	13"	13.3 mm	3,000 / Tape & Reel

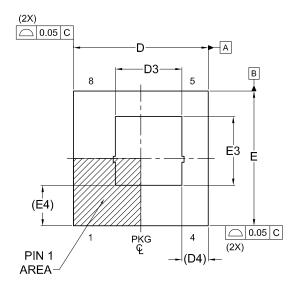
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <a href="https://example.com/BRD8011/D">BRD8011/D</a>.

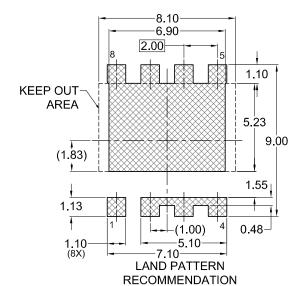




**PQFN8 8X8, 2P** CASE 483AQ **ISSUE B** 

**DATE 24 OCT 2022** 

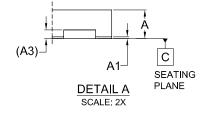




TOP VIEW SEE DETAIL A

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

## FRONT VIEW 0.10M C A B e1 05(M) C е b (8X) (8X) -(L1) PIN #1 IDENT NOTES: e2 E5 E2 e3 (4X) E6 (z)(4X)D2 **BOTTOM VIEW**



1. DIMENSIONING AND TOLERANCING PER ASME

- Y14.5M, 2009. 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.

DIM	MILLIMETERS				
Diw	MIN.	NOM.	MAX.		
Α	0.75	0.85	0.95		
A1	0.00	-	0.05		
A3	(	).25 REF	:		
b	0.90	1.00	1.10		
D	7.90	8.00	8.10		
D2	6.80	6.90	7.00		
D3	3.68	3.86	4.03		
D4	1.56 REF				
Е	7.90	8.00	8.10		
E2	5.13	5.23	5.33		
E3	3.99	4.09	4.19		
E4	2.41 REF				
E5	-	0.35 REF			
E6	0.60 REF				
е	2.00 BSC				
e1	6.00 BSC				
e2	1.20 BSC				
<b>e</b> 3	2.78 BSC				
k	1.48	1.58	1.68		
L	0.50	0.60	0.70		
L1	0.20 REF				
z	0.50 REF				

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